



N-Channel Enhancement-Mode Vertical DMOS FET

Features

- ▶ Low threshold (1.6V max.)
- ▶ High input impedance
- ▶ Low input capacitance
- ▶ Fast switching speeds
- ▶ Low on-resistance
- ▶ Free from secondary breakdown
- ▶ Low input and output leakage

Applications

- ▶ Logic level interfaces – ideal for TTL and CMOS
- ▶ Solid state relays
- ▶ Battery operated systems
- ▶ Photo voltaic drives
- ▶ Analog switches
- ▶ General purpose line drivers
- ▶ Telecom switches

General Description

This low threshold, enhancement-mode (normally-off) transistor utilizes a vertical DMOS structure and Supertex’s well-proven, silicon-gate manufacturing process. This combination produces a device with the power handling capabilities of bipolar transistors and with the high input impedance and positive temperature coefficient inherent in MOS devices. Characteristic of all MOS structures, this device is free from thermal runaway and thermally-induced secondary breakdown.

Supertex’s vertical DMOS FETs are ideally suited to a wide range of switching and amplifying applications where very low threshold voltage, high breakdown voltage, high input impedance, low input capacitance, and fast switching speeds are desired.

Ordering Information

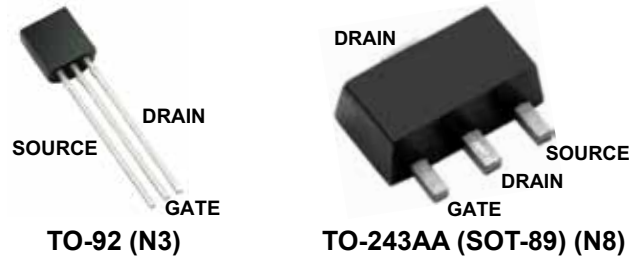
Device	Package Options		Wafer / Die Options		
	TO-92	TO-243AA (SOT-89)	NW (Die in wafer form)	NJ (Die on adhesive tape)	ND (Die in wafile pack)
TN0104	TN0104N3-G	TN0104N8-G	TN1504NW	TN1504NJ	TN1504ND

For packaged products, -G indicates package is RoHS compliant ('Green'). Devices in Wafer / Die form are RoHS compliant ('Green'). Refer to Die Specification VF15 for layout and dimensions.

Product Summary

Device	BV _{DSS} / BV _{DGS} (V)	R _{DS(ON)} (max) (Ω)	I _{D(ON)} (min) (A)	V _{GS(th)} (max) (V)
TN0104N3-G	40	1.8	2.0	1.6
TN0104N8-G	40	2.0	2.0	1.6

Pin Configurations



Absolute Maximum Ratings

Parameter	Value
Drain-to-source voltage	BV _{DSS}
Drain-to-gate voltage	BV _{DGS}
Gate-to-source voltage	±20V
Operating and storage temperature	-55°C to +150°C

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these conditions is not implied. Continuous operation of the device at the absolute rating level may affect device reliability. All voltages are referenced to device ground.

Product Marking



YY = Year Sealed
 WW = Week Sealed
 _____ = “Green” Packaging

Package may or may not include the following marks: Si or

TO-92 (N3)



W = Code for Week Sealed
 _____ = “Green” Packaging

Package may or may not include the following marks: Si or

TO-243AA (SOT-89) (N8)

Thermal Characteristics

Package	I_D (continuous) [†] (mA)	I_D (pulsed) (A)	Power Dissipation @ $T_c = 25^\circ\text{C}$ (W)	θ_{jc} ($^\circ\text{C}/\text{W}$)	θ_{ja} ($^\circ\text{C}/\text{W}$)	I_{DR} [†] (mA)	I_{DRM} (A)
TO-92	450	2.40	1.0	125	170	450	2.40
TO-243AA (SOT-89)	630	2.90	1.6 [‡]	15	78 [‡]	630	2.90

Notes:

[†] I_D (continuous) is limited by max rated T_j .

[‡] $T_A = 25^\circ\text{C}$. Mounted on FR5 Board, 25mm x 25mm x 1.57mm. Significant P_D increase possible on ceramic substrate.

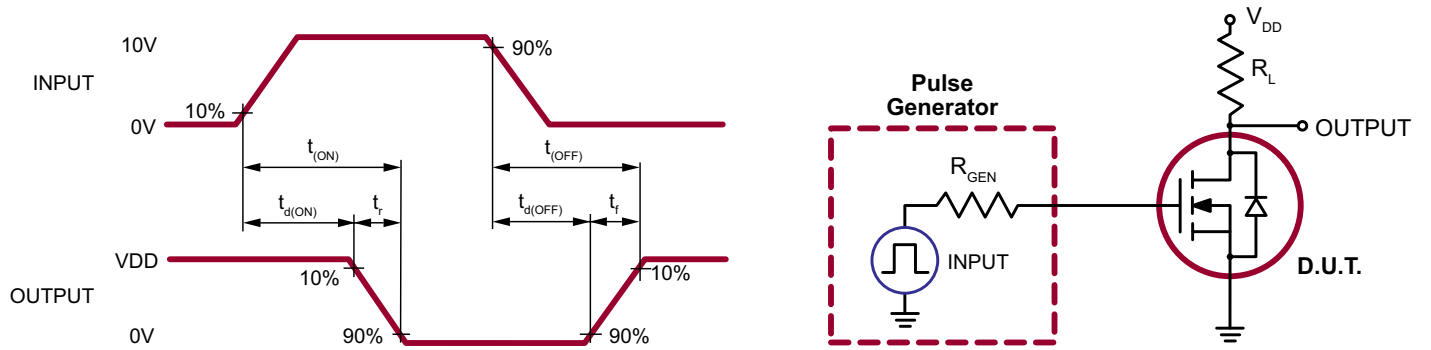
Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise specified)

Sym	Parameter	Min	Typ	Max	Units	Conditions		
BV_{DSS}	Drain-to-source breakdown voltage	40	-	-	V	$V_{GS} = 0V, I_D = 1.0\text{mA}$		
$V_{GS(th)}$	Gate threshold voltage	0.6	-	1.6	V	$V_{GS} = V_{DS}, I_D = 500\mu\text{A}$		
$\Delta V_{GS(th)}$	Change in $V_{GS(th)}$ with temperature	-	-3.8	-5.0	mV/ $^\circ\text{C}$	$V_{GS} = V_{DS}, I_D = 1.0\text{mA}$		
I_{GSS}	Gate body leakage	-	0.1	100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$		
I_{DSS}	Zero gate voltage drain current	-	-	1.0	μA	$V_{GS} = 0V, V_{DS} = \text{Max Rating}$		
		-	-	100		$V_{DS} = 0.8 \text{ Max Rating}, V_{GS} = 0V, T_A = 125^\circ\text{C}$		
$I_{D(ON)}$	On-state drain current	-	0.35	-	A	$V_{GS} = 3.0V, V_{DS} = 20V$		
		0.5	1.1	-		$V_{GS} = 5.0V, V_{DS} = 20V$		
		2.0	2.6	-		$V_{GS} = 10V, V_{DS} = 20V$		
$R_{DS(ON)}$	Static drain-to-source on-state resistance	Both packages		-	5.0	-	Ω	$V_{GS} = 3.0V, I_D = 50\text{mA}$
		TO-92		-	2.3	2.5		$V_{GS} = 5.0V, I_D = 250\text{mA}$
		TO-243AA		-	1.5	1.8		$V_{GS} = 10V, I_D = 1.0A$
				-	-	2.0		
$\Delta R_{DS(ON)}$	Change in $R_{DS(ON)}$ with temperature	-	0.7	1.0	%/ $^\circ\text{C}$	$V_{GS} = 10V, I_D = 1.0A$		
G_{FS}	Forward transductance	340	450	-	mmho	$V_{DS} = 20V, I_D = 500\text{mA}$		
C_{ISS}	Input capacitance	-	-	70	pF	$V_{GS} = 0V,$ $V_{DS} = 20V,$ $f = 1.0\text{MHz}$		
C_{OSS}	Common source output capacitance	-	-	50				
C_{RSS}	Reverse transfer capacitance	-	-	15				
$t_{d(ON)}$	Turn-on delay time	-	3.0	5.0	ns	$V_{DD} = 20V,$ $I_D = 1.0A,$ $R_{GEN} = 25\Omega$		
t_r	Rise time	-	7.0	8.0				
$t_{d(OFF)}$	Turn-off delay time	-	6.0	9.0				
t_f	Fall time	-	5.0	8.0				
V_{SD}	Diode forward voltage drop	TO-92	-	1.2	1.8	V	$V_{GS} = 0V, I_{SD} = 1.0A$	
		TO-243AA	-	-	2.0		$V_{GS} = 0V, I_{SD} = 0.5A$	
t_{rr}	Reverse recovery time	-	300	-	ns	$V_{GS} = 0V, I_{SD} = 1.0A$		

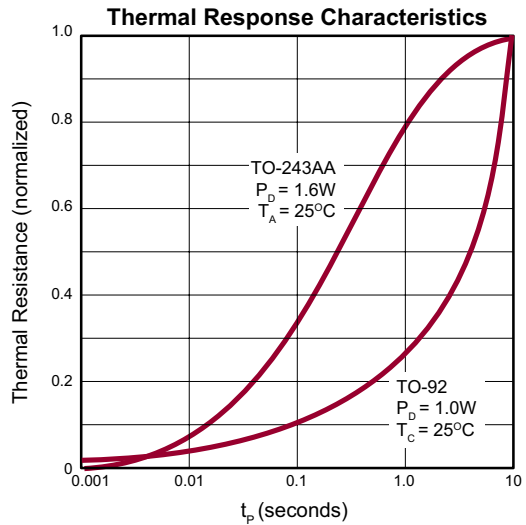
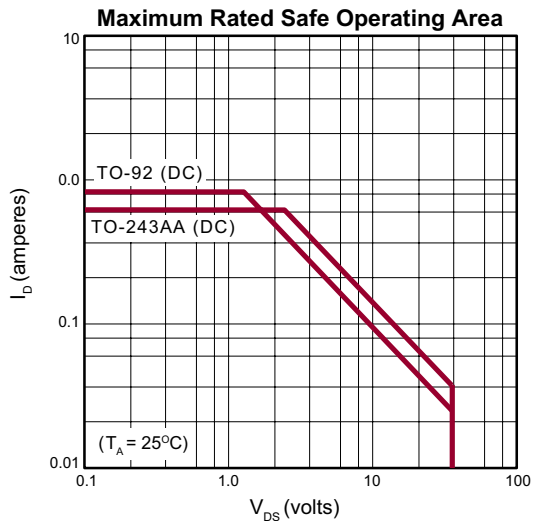
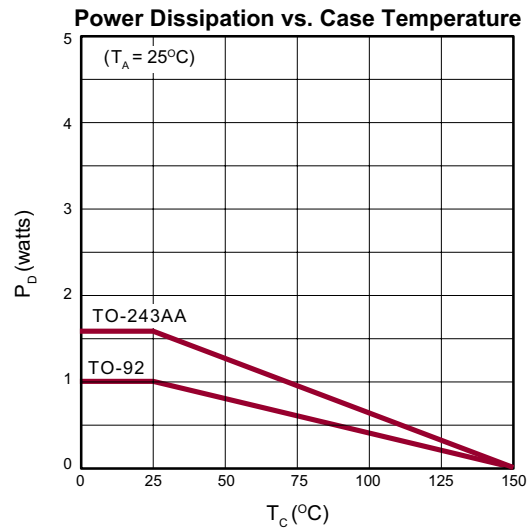
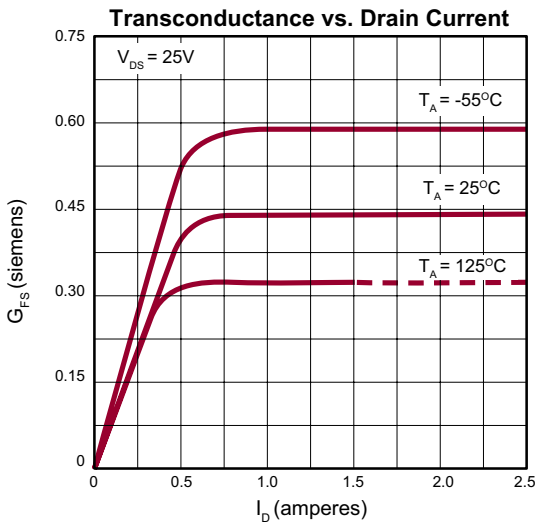
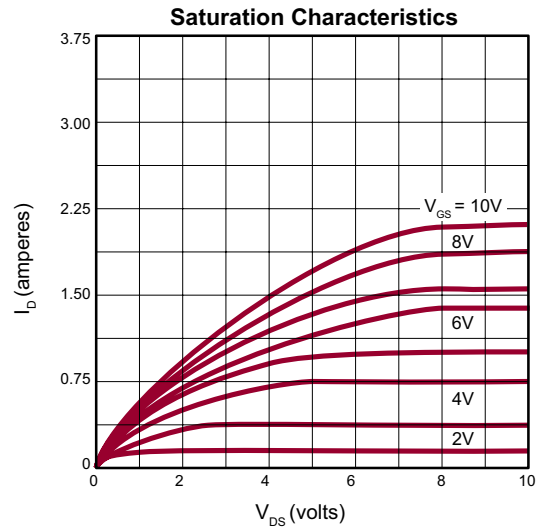
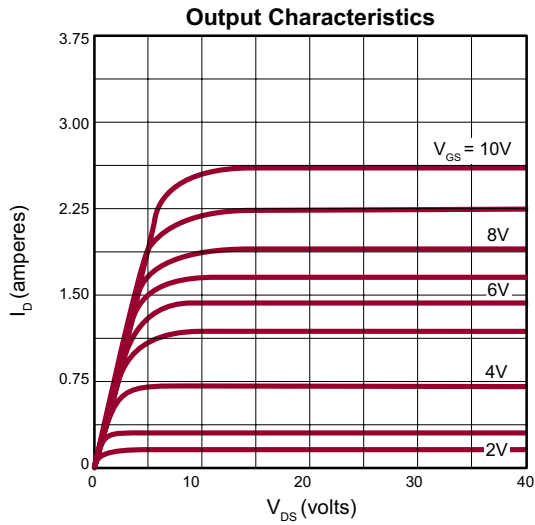
Notes:

- All D.C. parameters 100% tested at 25°C unless otherwise stated. (Pulse test: 300 μs pulse, 2% duty cycle.)
- All A.C. parameters sample tested.

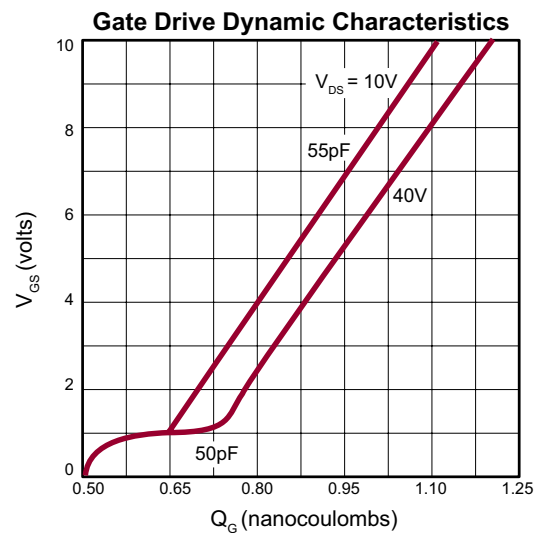
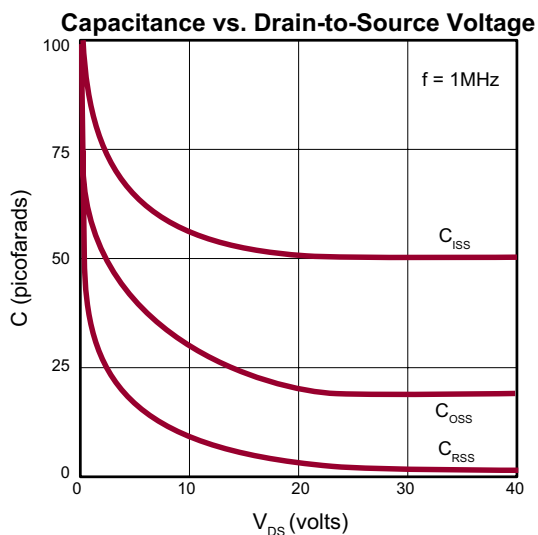
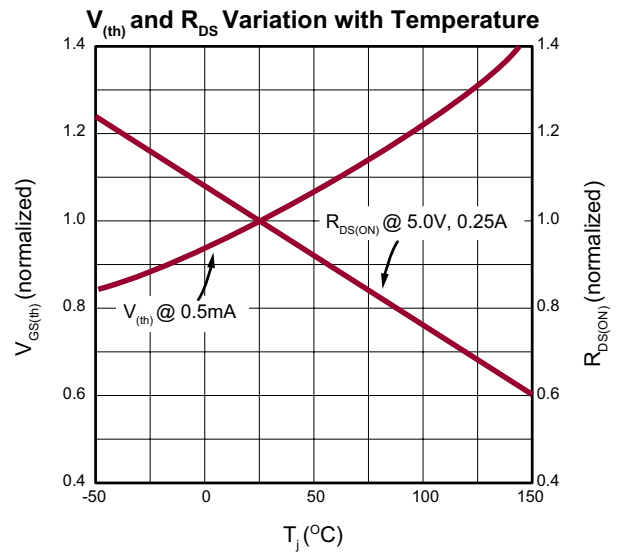
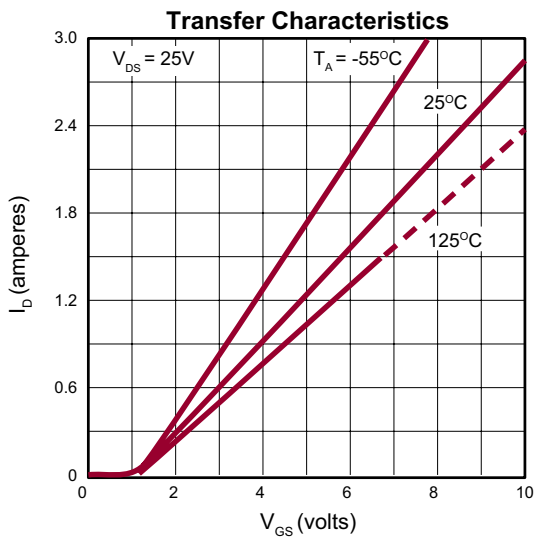
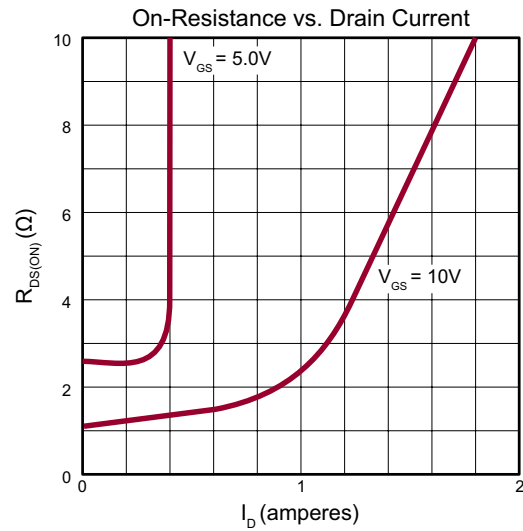
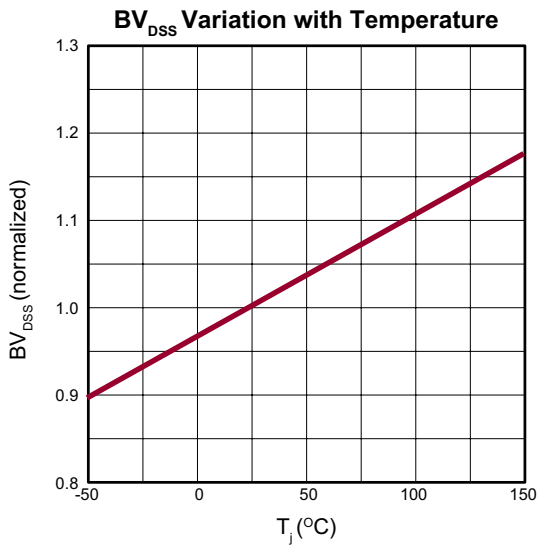
Switching Waveforms and Test Circuit



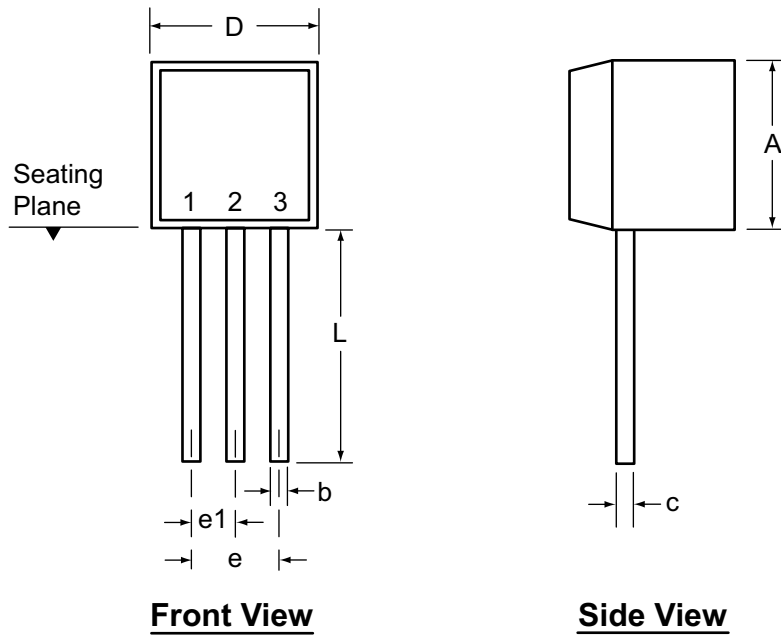
Typical Performance Curves



Typical Performance Curves (cont.)



3-Lead TO-92 Package Outline (N3)



Symbol	A	b	c	D	E	E1	e	e1	L	
Dimensions (inches)	MIN	.170	.014 [†]	.014 [†]	.175	.125	.080	.095	.045	.500
	NOM	-	-	-	-	-	-	-	-	-
	MAX	.210	.022 [†]	.022 [†]	.205	.165	.105	.105	.055	.610*

JEDEC Registration TO-92.

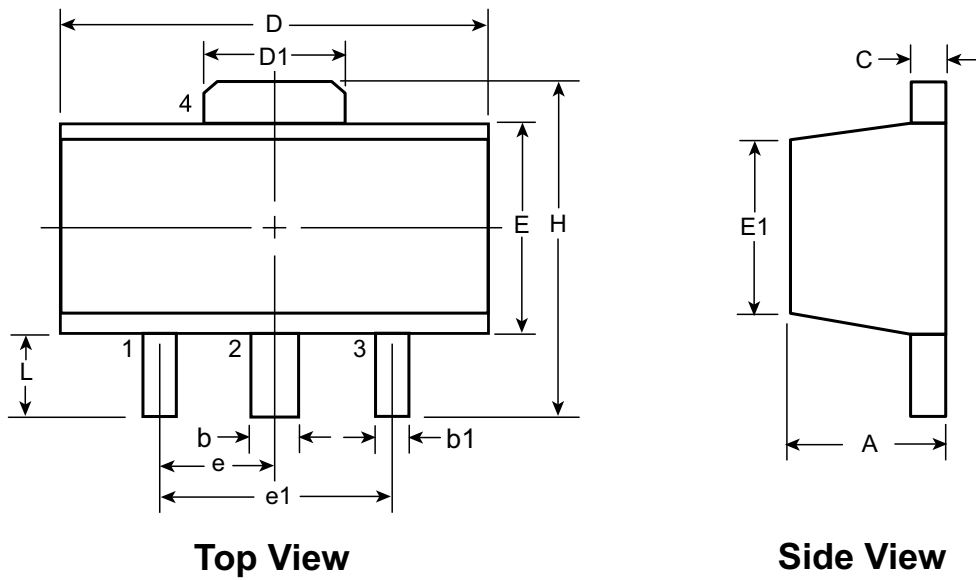
* This dimension is not specified in the JEDEC drawing.

† This dimension differs from the JEDEC drawing.

Drawings not to scale.

Supertex Doc.#: DSPD-3TO92N3, Version E041009.

3-Lead TO-243AA (SOT-89) Package Outline (N8)



Symbol		A	b	b1	C	D	D1	E	E1	e	e1	H	L	
Dimensions (mm)	MIN	1.40	0.44	0.36	0.35	4.40	1.62	2.29	2.00 [†]	1.50 BSC	3.00 BSC	3.94	0.73 [†]	
	NOM	-	-	-	-	-	-	-	-			-	-	-
	MAX	1.60	0.56	0.48	0.44	4.60	1.83	2.60	2.29			4.25	1.20	

JEDEC Registration TO-243, Variation AA, Issue C, July 1986.

[†] This dimension differs from the JEDEC drawing

Drawings not to scale.

Supertex Doc. #: DSPD-3TO243AAN8, Version F111010.

(The package drawing(s) in this data sheet may not reflect the most current specifications. For the latest package outline information go to <http://www.supertex.com/packaging.html>.)

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